

#### 200V N-Channel MOSFET

#### **General Description**

The 50N20 uses advanced planar stripe DMOS technology and design to provide excellent RDS(ON).

These devices are well suited for high efficient switching mode power supplies and active power factor correction.

#### **Features**

- Fast switching
- 100% avalanche tested
- Improve dv/dt capability
- RoHS compliant

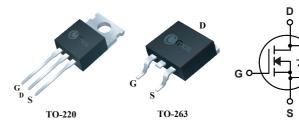
#### **Product Summary**

BVDSS RDS(on) max.		ID
200V	$55 m\Omega$	50A

# **Applications**

- Uninterruptible power supplies
- DC/DC converter
- DC/AC inverter

## **TO-220/263 Pin Configuration**



Туре	Package	Marking
CMP50N20	TO-220	CMP50N20
CMB50N20	TO-263	CMB50N20

## **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units	
$V_{DS}$	Drain-Source Voltage	200	V	
$V_{GS}$	Gate-Source Voltage	±20	V	
I <sub>D</sub> @T <sub>C</sub> =25℃	Continuous Drain Current	50	А	
I <sub>D</sub> @T <sub>C</sub> =100℃	Continuous Drain Current	40	А	
I <sub>DM</sub>	Pulsed Drain Current <sup>1</sup>	200	А	
EAS	Single Pulse Avalanche Energy <sup>2</sup>	1350	mJ	
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation	350	W	
T <sub>STG</sub>	Storage Temperature Range -55 to 175		$^{\circ}$	
$T_J$	Operating Junction Temperature Range	-55 to 175	$^{\circ}$	

## **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
$R_{ heta JA}$	Thermal Resistance Junction-ambient		60	°C/W
R <sub>eJC</sub>	Thermal Resistance Junction-case		0.4	°C/W

# CMP50N20/CMB50N20



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# Electrical Characteristics (T\_J=25 $^{\circ}$ C , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	200			V
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =25A			55	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	2		4	V
I <sub>DSS</sub>	Drain-Source Leakage Current	V <sub>DS</sub> =200V , V <sub>GS</sub> =0V			1	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ =±20V , $V_{DS}$ =0V			±100	nA
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =25A		35		S
$R_g$	Gate Resistance	$V_{DS}$ =0V , $V_{GS}$ =0V , f=1MHz		0.85		Ω
$Q_g$	Total Gate Charge	I <sub>D</sub> =52 A		50		
$Q_gs$	Gate-Source Charge	V <sub>DS</sub> = 160V		20		nC
$Q_gd$	Gate-Drain Charge	V <sub>GS</sub> = 10 V		25		
T <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> =100 V		50		
Tr	Rise Time			172		no
T <sub>d(off)</sub>	Turn-Off Delay Time	I <sub>D</sub> =20A		50		ns
T <sub>f</sub>	Fall Time	R <sub>G</sub> =25Ω		30		
C <sub>iss</sub>	Input Capacitance			3700		
Coss	Output Capacitance	V <sub>DS</sub> =25V , V <sub>GS</sub> =0V , f=1MHz		550		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			65		

## **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	-V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			50	Α
I <sub>SM</sub>	Pulsed Source Current				200	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>F</sub> =25A , T <sub>J</sub> =25℃			1.2	V
trr	Reverse Recovery Time	V <sub>GS</sub> =0V, I <sub>F</sub> =50A		282		ns
Qrr	Reverse Recovery Charge	dıғ /dt=100A/µs		2.3		μC

#### Note

1.Repetitive rating; pulse width limited by maximum junction temperature.

2. The test condition is  $V_{DD}$ =50V,  $V_{GS}$ =10V, L=1mH,  $I_{AS}$ =58A.

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